

PCTEST ENGINEERING LABORATORY, INC.

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MEASUREMENT REPORT FCC PART 15.247 WLAN 802.11a/n/ac

Applicant Name:

Samsung Electronics, Co. Ltd. 129, Samsung-ro, Maetan dong, Yeongtong-gu, Suwon-si Gyeonggi-do 443-742, Korea

Date of Testing: 7/19/2013 Test Site/Location: PCTEST Lab, Columbia, MD, USA Test Report Serial No.: 0Y1307101234.A3L

FCC ID:	A3LSCHI545	
APPLICANT:	Samsung Electronics, Co. Ltd.	
Application Type:	Class II Permissive Change	
Model(s):	SCH-I545	
EUT Type:	Portable Handset	
FCC Classification:	Digital Transmission System (DTS)	
FCC Rule Part(s):	Part 15.247	
Test Procedure(s):	KDB 558074 v03r01, KDB 648474 v01r02	
Class II Permissive Change:	Please see FCC change documents.	
Original Grant Date:	03/29/2013	

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in KDB 558074 v03r01. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Randy Ortanez President



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MEASUREMENT REPORT FCC Part 15.247



§ 2.1033 General Information

APPLICANT:	Samsung Electronics, Co. Ltd.				
APPLICANT ADDRESS:	129, Samsung-ro, Ma	129, Samsung-ro, Maetan dong,			
	Yeongtong-gu, Suwo	n-si, Gyeonggi-do	o 443-742, Korea		
TEST SITE:	PCTEST ENGINEER	ING LABORATO	RY, INC.		
TEST SITE ADDRESS:	7185 Oakland Mills R	oad, Columbia, N	/ID 21046 USA		
FCC RULE PART(S):	Part 15.247				
IC SPECIFICATION(S):	RSS-210 Issue 8				
MODEL NAME:	SCH-1545				
FCC ID:	A3LSCHI545				
Test Device Serial No.:	FK-195-B	Production	Pre-Production		
FCC CLASSIFICATION:	Digital Transmission System (DTS)				
DATE(S) OF TEST:	7/19/2013				
TEST REPORT S/N:	0Y1307101234.A3L				

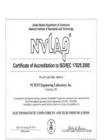
Test Facility / Accreditations

Measurements were performed at PCTEST Engineering Lab located in Columbia, MD 21046, U.S.A.



- PCTEST facility is an FCC registered (PCTEST Reg. No. 159966) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (2451B-1).
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing Aid Compatibility (HAC) testing, CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and Industry Canada Standards (RSS).
- PCTEST facility is an IC registered (2451B-1) test laboratory with the site description on file at Industry Canada.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS, CDMA, and EvDO wireless devices and for Over-the-Air (OTA) Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS (W-CDMA), CDMA 1xEVDO, and CDMA 1xRTT.

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1.0 INTRODUCTION

1.1 Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Industry Canada Certification and Engineering Bureau.

1.2 PCTEST Test Location

The map below shows the location of the PCTEST LABORATORY, its proximity to the FCC Laboratory, the Columbia vicinity, the Baltimore-Washington Internt'I (BWI) airport, the city of Baltimore and the Washington, DC area. (See Figure 1-1).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility located at 7185 Oakland Mills Road, Columbia, MD 21046. The site coordinates are 39° 10'23" N latitude and 76° 49'50" W longitude. The facility is 0.4 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4-2009 on February 15, 2012.

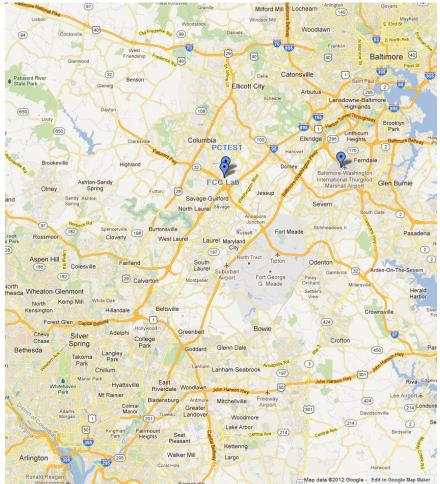


Figure 1-1. Map of the Greater Baltimore and Metropolitan Washington, D.C. area

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2.0 **PRODUCT INFORMATION**

2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3LSCHI545**. The test data contained in this report pertains only to the 5GHz emissions of the EUT's WLAN (DTS) transmitter since the change is not associated with the 2.4GHz operation.

2.2 Device Capabilities

This device contains the following capabilities:

850/1900 CDMA/EvDO Rev0/A (BC0, BC1), 850/1900 GSM/GPRS/EDGE, 850/1900 WCDMA/HSPA, Band 4(5,10,15,20 MHz BW), 13 (5,10 MHz BW) LTE, 802.11a/ac/b/g/n WLAN (DTS/NII), Bluetooth (1x,EDR, LE), NFC

2.3 Test Configuration

The Samsung Portable Handset FCC ID: A3LSCHI545 was tested per the guidance of KDB 558074 v03r01. ANSI C63.10-2009 was used to reference the appropriate EUT setup for radiated spurious emissions testing and AC line conducted testing. See Sections 3.2, and 6.1 of this test report for a description of the radiated emissions test setup.

This device supports a wireless charging cover. Additional emissions testing was performed per KDB 648474 D03 v01r02. The handset was placed on the representative charging pad (FCC ID: A3LEPP100IJWU) under normal conditions and in a simulated call configuration. The additional worst case emissions are reported herein and identified as WCC.

2.4 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and/or no modifications were made during testing.

2.5 Labeling Requirements

Per 2.1074 & 15.19; Docket 95-19

The label shall be permanently affixed at a conspicuous location on the device; instruction manual or pamphlet supplied to the user and be readily visible to the purchaser at the time of purchase. However, when the device is so small wherein placement of the label with specified statement is not practical, only the trade name and FCC ID must be displayed on the device per Section 15.19(a)(5). Please see attachment for FCC ID label and label location.

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3.0 DESCRIPTION OF TEST

3.1 Evaluation Procedure

The measurement procedures described in the American National Standard for Testing Unlicensed Wireless Devices (ANSI C63.10-2009), and the guidance provided in KDB 558074 v03r01 were used in the measurement of the **Samsung Portable Handset FCC ID: A3LSCHI545.**

Deviation from measurement procedure.....None

3.2 Radiated Emissions

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. For measurements above 1GHz absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections. For measurements below 1GHz, the absorbers are removed. An ETS Lindgren Model 2188 raised turntable is used for radiated measurement. It is a continuously rotatable, remote-controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. A 78cm high PVC support structure is placed on top of the turntable. A ³/₄" (~1.9cm) sheet of high density polyethylene is used as the table top and is placed on top of the PVC supports to bring the total height of the table to 80cm.

For all measurements, the spectrum was scanned through all EUT azimuths and from 1 to 4 meter receive antenna height using a broadband antenna from 30MHz up to the upper frequency shown in 15.33(b)(1) depending on the highest frequency generated or used in the device or on which the device operates or tunes. For frequencies above 1GHz, linearly polarized double ridge horn antennas were used. For frequencies below 30MHz, a calibrated loop antenna was used. When exploratory measurements were necessary, they were performed at 1 meter test distance inside the semi-anechoic chamber using broadband antennas, broadband amplifiers, and spectrum analyzers to determine the frequencies and modes producing the maximum emissions. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The test set-up was placed on top of the 0.8 meter high, 1 x 1.5 meter table. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Appropriate precaution was taken to ensure that all emissions from the EUT were maximized and investigated. The system configuration, clock speed, mode of operation or video resolution, if applicable, turntable azimuth, and receive antenna height was noted for each frequency found.

Final measurements were made in the semi-anechoic chamber using calibrated, linearly polarized broadband and horn antennas. The test setup was configured to the setup that produced the worst case emissions. The spectrum analyzer was set to investigate all frequencies required for testing to compare the highest radiated disturbances with respect to the specified limits. The turntable containing the EUT was rotated through 360 degrees and the height of the receive antenna was varied 1 to 4 meters and stopped at the azimuth and height producing the maximum emission. Each emission was maximized by changing the orientation of the EUT through three orthogonal planes and changing the polarity of the receive antenna, whichever produced the worst-case emissions. For the EUT positioning, "H" is defined with the EUT lying flat on the test surface, "H2" is defined with the EUT standing up on its side, and "V" is defined with the EUT standing upright.

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4.0 ANTENNA REQUIREMENTS

Excerpt from §15.203 of the FCC Rules/Regulations:

"An intentional radiator antenna shall be designed to ensure that no antenna other than that furnished by the responsible party can be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section."

- The antennas of the Portable Handset are **permanently attached**.
- There are no provisions for connection to an external antenna.

Conclusion:

The Samsung Portable Handset FCC ID: A3LSCHI545 unit complies with the requirement of §15.203.

Ch.	BW (MHz)	Frequency (MHz)
149	20	5745
151	20 / 40	5755
153	20	5765
155	20 / 80	5775
157	20	5785

Ch.	BW (MHz)	Frequency (MHz)
159	20 / 40	5795
161	20	5805
163	20	5815
165	20	5825

Table 4-1. Frequency/ Channel Operations

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5.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST).

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	RE1	Radiated Emissions Cable Set (UHF/EHF)	3/29/2013	Annual	3/29/2014	N/A
-	RE2	Radiated Emissions Cable Set (VHF/UHF)	3/29/2013	Annual	3/29/2014	N/A
Agilent	8447D	Broadband Amplifier	5/31/2013	Annual	5/31/2014	2443A01900
Com-Power	AL-130	9kHz - 30MHz Loop Antenna	6/26/2013	Annual	6/26/2014	121034
Emco	3115	Horn Antenna (1-18GHz)	1/12/2012	Biennial	1/12/2014	9704-5182
ETS Lindgren	3160-09	18-26.5 GHz Standard Gain Horn	5/30/2012	Biennial	5/30/2014	135427
ETS Lindgren	3160-10	26.5-40 GHz Standard Gain Horn	6/6/2012	Biennial	6/6/2014	130993
Huber+Suhner	Sucoflex 102A	40GHz Radiated Cable	3/1/2013	Annual	3/1/2014	251425001
K & L	6000/T18000	High Pass Filter	3/4/2013	Annual	3/4/2014	1
Rohde & Schwarz	TS-PR18	1-18 GHz Pre-Amplifier	5/31/2013	Annual	5/31/2014	100071
Rohde & Schwarz	TS-PR26	18-26.5 GHz Pre-Amplifier	5/31/2013	Annual	5/31/2014	100040
Rohde & Schwarz	TS-PR40	26.5-40 GHz Pre-Amplifier	6/6/2012	Biennial	6/6/2014	100037
Rohde & Schwarz	ESU26	EMI Test Receiver	2/25/2013	Annual	2/25/2014	100342
Sunol	JB5	Bi-Log Antenna (30M - 5GHz)	1/26/2012	Biennial	1/26/2014	A051107

Table 5-1. Annual Test Equipment Calibration Schedule

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6.0 TEST RESULTS

6.1 Summary

Company Name:	Samsung Electronics, Co. Ltd.
FCC ID:	A3LSCHI545
FCC Classification:	Digital Transmission System (DTS)
Data Rate(s) Tested:	<u>6Mbps, 9Mbps, 12Mbps, 18Mbps, 24Mbps, 36Mbps, 48Mbps, 54Mbps (a)</u>
	<u>6.5/7.2Mbps, 13/14.4Mbps, 19.5/21.7Mbps, 26/28.9Mbps, 39/43.3Mbps, 52/57.8Mbps, 58.5/65Mbps, 65/72.2Mbps (n – 20MHz)</u>
	<u>13.5/15Mbps, 27/30Mbps, 40.5/45Mbps, 54/60Mbps, 81/90Mbps, 108/120Mbps, 121.5/135Mbps, 135/150Mbps (n – 40MHz)</u>
	29.3/32.5Mbps, 58.5/65Mbps, 87.8/97.5Mbps, 117/130Mbps, 175.5/195Mbps, 234/260Mbps, 263.3/292.5Mbps, 292.5/325Mbps, 351/390Mbps, 390/433.3Mbps (ac – 80MHz BW)

FCC Part Section(s)	RSS Section(s)	Test Description	Test Limit	Test Condition	Test Result	Reference
15.205 15.209	RSS-210 [A8.5]	General Field Strength Limits (Restricted Bands and Radiated Emission Limits)	Emissions in restricted bands must meet the radiated limits detailed in 15.209	RADIATED	PASS	Sections 6.2, 6.3

Table 6-1. Summary of Test Results

Notes:

All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions.

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6.2 Radiated Spurious Emission Measurements §15.247(d) / §15.205 & §15.209; RSS-210 [A8.5]

Test Overview and Limit

All out of band radiated spurious emissions are measured with a spectrum analyzer connected to a receive antenna while the EUT is operating at its maximum duty cycle (>98%), at maximum power, and at the appropriate frequencies. All data rates and modes were investigated for radiated spurious emissions. Only the radiated emissions of the configuration that produced the worst case emissions are reported in this section.

All out of band emissions appearing in a restricted band as specified in Section 15.205 of the Title 47 CFR must not exceed the limits shown in Table 6-2 per Section 15.209.

Frequency	Field Strength [μV/m]	Measured Distance [Meters]
0.009 – 0.490 MHz	2400/F (kHz)	300
0.490 – 1.705 MHz	24000/F (kHz)	30
1.705 – 30.00 MHz	30	30
30.00 – 88.00 MHz	100	3
88.00 – 216.0 MHz	150	3
216.0 – 960.0 MHz	200	3
Above 960.0 MHz	500	3

Table 6-2. Radiated Limits

Test Procedures Used

KDB 558074 v03r01 – Section 12.2.5 (average power measurements)

KDB 558074 v03r01 - Section 12.2.4 (peak power measurements)

Test Settings

Average Field Strength Measurements per Section 12.2.5.1 of KDB 558074 v03r01

- 1. Analyzer center frequency was set to the frequency of the radiated spurious emission of interest
- 2. RBW = 1MHz
- 3. VBW = 3MHz
- 4. Detector = power average (RMS)
- 5. Number of measurement points = 1001 (Number of points must be $\geq 2 \times \text{span/RBW}$)
- 6. Sweep time = auto
- 7. Trace (RMS) averaging was performed over at least 100 traces

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Peak Field Strength Measurements per Section 12.2.4 of KDB 558074 v03r01

- 1. Analyzer center frequency was set to the frequency of the radiated spurious emission of interest
- 2. RBW = 1MHz
- 3. VBW = 3MHz
- 4. Detector = peak
- 5. Sweep time = auto couple
- 6. Trace mode = max hold
- 7. Trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

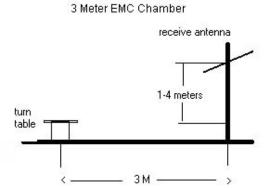


Figure 6-1. Test Instrument & Measurement Setup

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Test Notes

- The optional test procedures for antenna port conducted measurements of unwanted emissions per the guidance of KDB 558074 v03r01 were not used to evaluate this device for compliance to radiated limits. All radiated spurious emissions levels were measured in a radiated test setup.
- 2. All emissions lying in restricted bands specified in §15.205 are below the limit shown in Table 6-2.
- 3. The antenna is manipulated through typical positions, polarity and length during the tests. The EUT is manipulated through three orthogonal planes.
- 4. This unit was tested with its standard battery.
- 5. The spectrum is measured from 9kHz to the 10th harmonic of the fundamental frequency of the transmitter using CISPR quasi peak detector below 1GHz. Above 1 GHz, average and peak measurements were taken using linearly polarized horn antennas. The worst-case emissions are reported however emissions whose levels were not within 20dB of the respective limits were not reported.
- 6. Emissions below 18GHz were measured at a 3 meter test distance while emissions above 18GHz were measured at a 1 meter test distance with the application of a distance correction factor.
- Average levels at -135dBm and peak levels at -125dBm represent the analyzer noise floor and signify that no emission was detected.

Sample Calculations

Determining Spurious Emissions Levels

- Field Strength Level [dBµV/m] = Analyzer Level [dBm] + 107 + AFCL [dB/m]
- AFCL [dB/m] = Antenna Factor [dB/m] + Cable Loss [dB]
- Margin [dB] = Field Strength Level $[dB\mu V/m]$ Limit $[dB\mu V/m]$

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Radiated Spurious Emission Measurements (Cont'd) §15.247(d) / §15.205 & §15.209; RSS-210 [A8.5]

Worst Case Mode:	802.11a
Worst Case Transfer Rate:	6 Mbps
Distance of Measurements:	1 & 3 Meters
Operating Frequency:	5745MHz
Channel:	149

Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Distance Correction Factor [dB]	Field Strength [dB _µ V/m]	Limit [dB _µ V/m]	Margin [dB]
11490.00	-114.98	Avg	Н	49.71	0.00	41.73	53.98	-12.25
11490.00	-101.78	Peak	Н	49.71	0.00	54.93	73.98	-19.05
22980.00	-135.00	Avg	Н	44.53	-9.54	16.53	53.98	-37.45
22980.00	-125.00	Peak	Н	44.53	-9.54	26.53	73.98	-47.45

Table 6-3. Radiated Measurements

Radiated Spurious Emission Measurements (Cont'd) §15.247(d) / §15.205 & §15.209; RSS-210 [A8.5]

Worst Case Mode:	802.11a
Worst Case Transfer Rate:	6 Mbps
Distance of Measurements:	1 & 3 Meters
Operating Frequency:	5785MHz
Channel:	157

Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Field Strength [dB _µ V/m]	Limit [dBµV/m]	Margin [dB]
11570.00	-114.01	Avg	Н	49.87	42.86	53.98	-11.12
11570.00	-100.38	Peak	Н	49.87	56.49	73.98	-17.49

Table 6-4. Radiated Measurements

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Radiated Spurious Emission Measurements (Cont'd) §15.247(d) / §15.205 & §15.209; RSS-210 [A8.5]

Worst Case Mode:	802.11a
Worst Case Transfer Rate:	6 Mbps
Distance of Measurements:	1 & 3 Meters
Operating Frequency:	5825MHz
Channel:	165

Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Field Strength [dBµV/m]	Limit [dBµV/m]	Margin [dB]
11650.00	-114.36	Avg	Н	50.04	42.68	53.98	-11.30
11650.00	-101.21	Peak	Н	50.04	55.83	73.98	-18.15

Table 6-5. Radiated Measurements

FCC ID: A3LSCHI545		FCC Pt. 15.247 802.11a/n/ac MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager	
Test Report S/N:	Test Dates:	EUT Type:		Dage 14 of 16	
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6.3 Radiated Spurious Emission Measurements with WCC §15.247(d) / §15.205 & §15.209; RSS-210 [A8.5]

Worst Case Mode:	802.11a with WCC
Worst Case Transfer Rate:	6 Mbps
Distance of Measurements:	1 & 3 Meters
Operating Frequency:	5745MHz
Channel:	149

Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Distance Correction Factor [dB]	Field Strength [dB _µ V/m]	Limit [dBµV/m]	Margin [dB]
11490.00	-115.33	Avg	Н	49.71	0.00	41.38	53.98	-12.60
11490.00	-102.55	Peak	Н	49.71	0.00	54.16	73.98	-19.82
22980.00	-135.00	Avg	Н	44.53	-9.54	16.53	53.98	-37.45
22980.00	-160.98	Peak	Н	44.53	-9.54	26.53	73.98	-47.45

Table 6-6. Radiated Measurements

FCC ID: A3LSCHI545		FCC Pt. 15.247 802.11a/n/ac MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager	
Test Report S/N:	Test Dates:	EUT Type:		Dage 15 of 16	
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CONCLUSION 7.0

The data collected relate only the item(s) tested and show that the Samsung Portable Handset FCC ID: A3LSCHI545 is in compliance with Part 15C of the FCC Rules.

FCC ID: A3LSCHI545		FCC Pt. 15.247 802.11a/n/ac MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager	
Test Report S/N:	Test Dates:	EUT Type:		Dage 16 of 16	
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